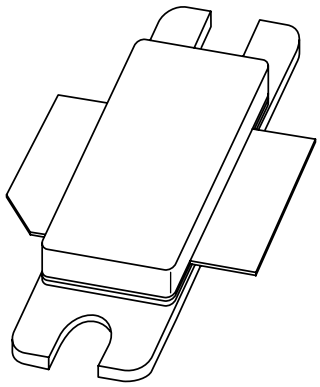
DATA SHEET



BLF2022-90
UHF power LDMOS transistor

Product specification
Supersedes data of 2002 Sep 09

2003 Feb 24

Philips
Semiconductors

UHF power LDMOS transistor BLF2022-90

FEATURES

- Typical W-CDMA performance at a supply voltage of 28 V and I_{DQ} of 750 mA:
  - Output power = 11.5 W (AV)
  - Gain = 12.5 dB
  - Efficiency = 20%
  - ACPR = –42 dBc at 3.84 MHz
  - d_{im} = –36 dBc
- Easy power control
- Excellent ruggedness
- High power gain
- Excellent thermal stability
- Designed for broadband operation (2000 to 2200 MHz)
- Internally matched for ease of use.

APPLICATIONS

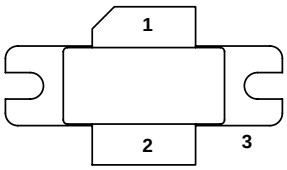
- RF power amplifiers for W-CDMA base stations and multicarrier applications in the 2000 to 2200 MHz frequency range.

DESCRIPTION

90 W LDMOS power transistor for base station applications at frequencies from 2000 to 2200 MHz.

PINNING - SOT502A

PIN	DESCRIPTION
1	drain
2	gate
3	source, connected to flange



Top view MBK394

Fig.1 Simplified outline.

QUICK REFERENCE DATA

Typical RF performance at T_h = 25 °C in a common source class-AB test circuit.

MODE OF OPERATION	f (MHz)	V_{DS} (V)	I_{DQ} (mA)	P_L (W)	G_p (dB)	η_D (%)	d_{im} (dBc)	$ACLR_5$ (dBc)
2-tone, class-AB	f_1 = 2170; f_2 = 2170.1	28	750	90 (PEP)	12.8	35.7	–28.5	–
W-CDMA, 3GPP test model 1, 64 channels with 66% clipping	2140	28	750	15 (AV)	13.2	20	–	–40

CAUTION
This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling. For further information, refer to Philips specs.: SNW-EQ-608, SNW-FQ-302A and SNW-FQ-302B.

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	MIN.	MAX.	UNIT
V_{DS}	drain-source voltage	–	65	V
V_{GS}	gate-source voltage	–	±15	V
I_D	DC drain current	–	12	A
T_{stg}	storage temperature	–65	+150	°C
T_j	junction temperature	–	200	°C

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
$R_{th\ j\text{-}c}$	thermal resistance from junction to case	T_h = 25 °C; note 1	0.65	K/W
$R_{th\ c\text{-}h}$	thermal resistance from case to heatsink	T_h = 25 °C; note 2	0.2	K/W

Notes

1. Thermal resistance is determined under specified RF operating conditions.
2. Depending on mounting conditions.

CHARACTERISTICS

T_j = 25 °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(BR)DSS}$	drain-source breakdown voltage	V_{GS} = 0; I_D = 2.1 mA	65	–	–	V
V_{GSth}	gate-source threshold voltage	V_{DS} = 10 V; I_D = 210 mA	4.4	–	5.5	V
I_{DSS}	drain-source leakage current	V_{GS} = 0; V_{DS} = 26 V	–	–	15	μA
I_{DSX}	on-state drain current	V_{GS} = V_{GSth} + 9 V; V_{DS} = 10 V	27	–	–	A
I_{GSS}	gate leakage current	V_{GS} = ±15 V; V_{DS} = 0	–	–	38	nA
g_{fs}	forward transconductance	V_{DS} = 10 V; I_D = 7.5 A	–	6.2	–	S
R_{DSon}	drain-source on-state resistance	V_{GS} = V_{GSth} + 9 V; I_D = 7.5 A	–	0.1	–	Ω
C_{rs}	feedback capacitance	V_{GS} = 0; V_{DS} = 26 V; f = 1 MHz	–	5.1	–	pF

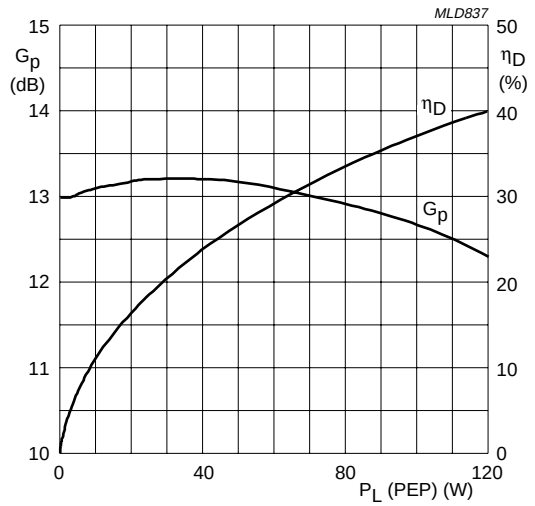
APPLICATION INFORMATION

RF performance in a common source class-AB circuit. T_h = 25 °C; $R_{th\ j\text{-}c}$ = 0.65 K/W; unless otherwise specified.

MODE OF OPERATION	f (MHz)	V_{DS} (V)	I_{DQ} (mA)	P_L (W)	G_p (dB)	η_D (%)	d_{im} (dBc)
2-tone, class-AB	f_1 = 2170; f_2 = 2170.1	28	750	90 (PEP)	>11	>30	≤–25

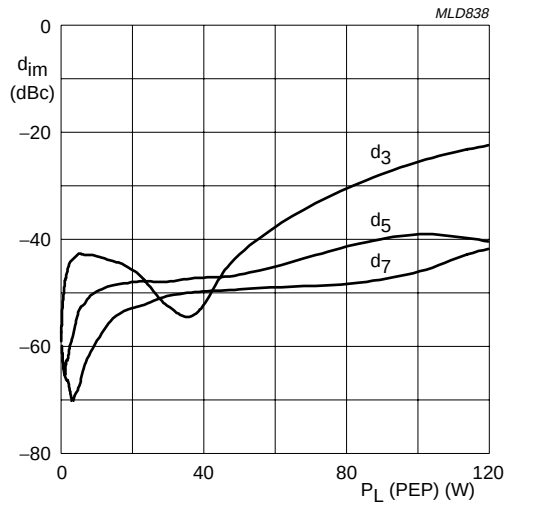
Ruggedness in class-AB operation

The BLF2022-90 is capable of withstanding a load mismatch corresponding to VSWR = 10 : 1 through all phases under the following conditions: V_{DS} = 28 V; I_{DQ} = 750 mA; P_L = 90 W (CW); f = 2170 MHz.



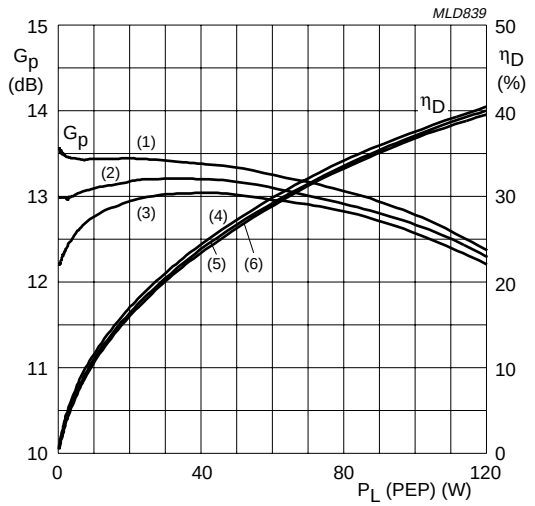
V_{DS} = 28 V; I_{DQ} = 750 mA; T_h = 25 °C;
f_1 = 2170 MHz; f_2 = 2170.1 MHz.

Fig.2 Power gain and drain efficiency as functions of peak envelope load power; typical values.



V_{DS} = 28 V; I_{DQ} = 750 mA; T_h = 25 °C;
f_1 = 2170 MHz; f_2 = 2170.1 MHz.

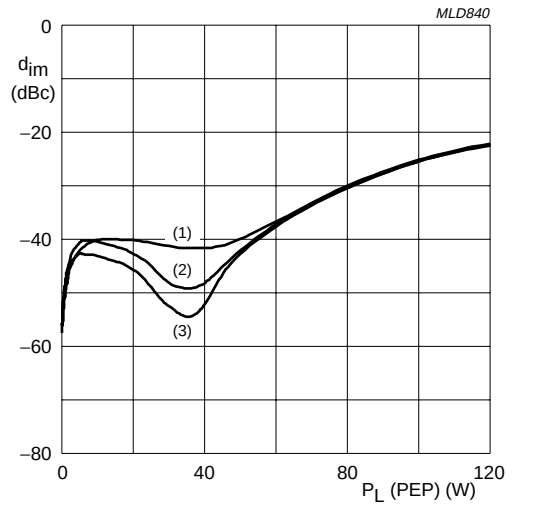
Fig.3 Intermodulation distortion as a function of peak envelope load power; typical values.



V_{DS} = 28 V; T_h = 25 °C;
f_1 = 2170 MHz; f_2 = 2170.1 MHz.

(1) I_{DQ} = 900 mA. (3) I_{DQ} = 600 mA. (5) I_{DQ} = 750 mA.
(2) I_{DQ} = 750 mA. (4) I_{DQ} = 600 mA. (6) I_{DQ} = 900 mA.

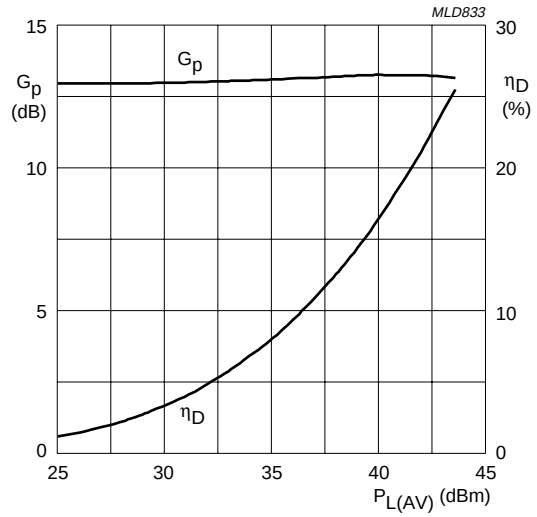
Fig.4 Power gain and drain efficiency as functions of peak envelope load power; typical values.



V_{DS} = 28 V; T_h = 25 °C;
f_1 = 2170 MHz; f_2 = 2170.1 MHz.

(1) I_{DQ} = 600 mA. (2) I_{DQ} = 900 mA. (3) I_{DQ} = 750 mA.

Fig.5 Third order intermodulation distortion as a function of peak envelope load power; typical values.



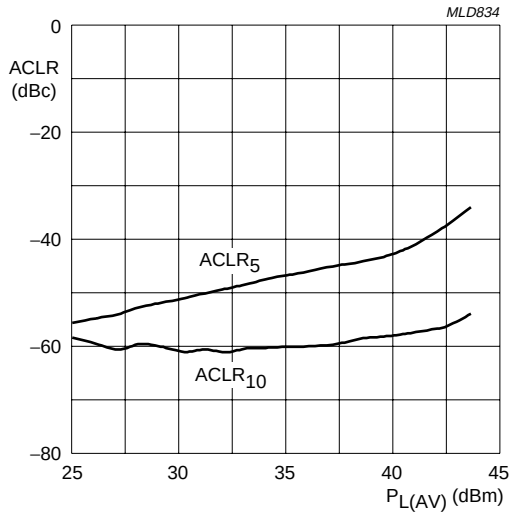
Single carrier W-CDMA performance.

V_{DS} = 28 V; I_{DQ} = 750 mA; T_h = 25 °C; f = 2140 MHz.

Input signal: 3GPP W-CDMA 1-64DPCH with 66% clipping; peak to average power ratio: 8.5 dB at 0.01% probability on CCDF; channel spacing/bandwidth = 5 MHz / 3.84 MHz.

Measured in a W-CDMA application circuit.

Fig.6 Power gain and drain efficiency as functions of average load power; typical values.



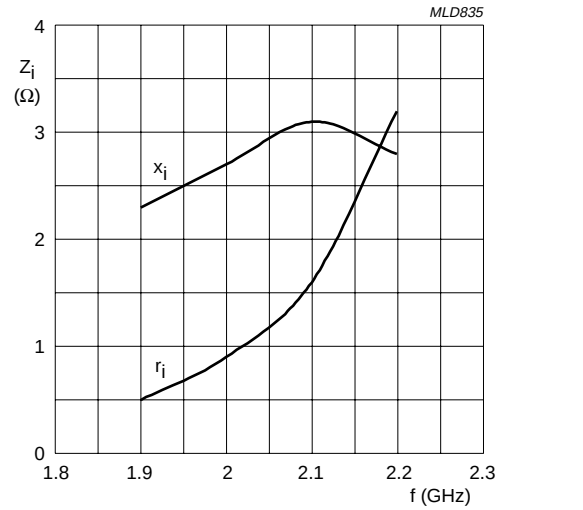
Single carrier W-CDMA performance.

V_{DS} = 28 V; I_{DQ} = 750 mA; T_h = 25 °C; f = 2140 MHz.

Input signal: 3GPP W-CDMA 1-64DPCH with 66% clipping; peak to average power ratio: 8.5 dB at 0.01% probability on CCDF; channel spacing/bandwidth = 5 MHz / 3.84 MHz.

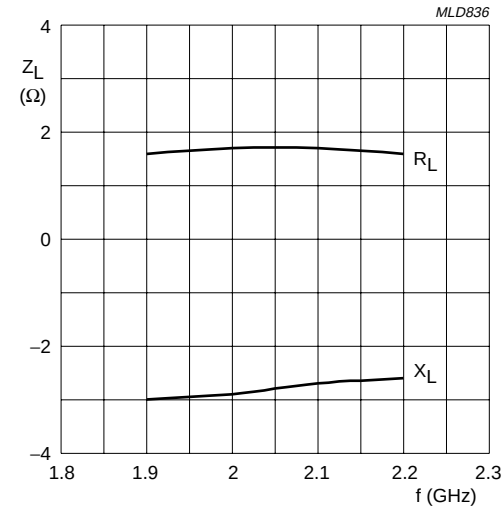
Measured in a W-CDMA application circuit.

Fig.7 Adjacent channel leakage ratio ($ACLR_5$ and $ACLR_{10}$) as function of average load power; typical values.



V_{DS} = 28 V; I_D = 750 mA; P_L = 90 W; T_h = 25 °C.

Fig.8 Input impedance as a function of frequency (series components); typical values.



V_{DS} = 28 V; I_D = 750 mA; P_L = 90 W; T_h = 25 °C.

Fig.9 Load impedance as a function of frequency (series components); typical values.

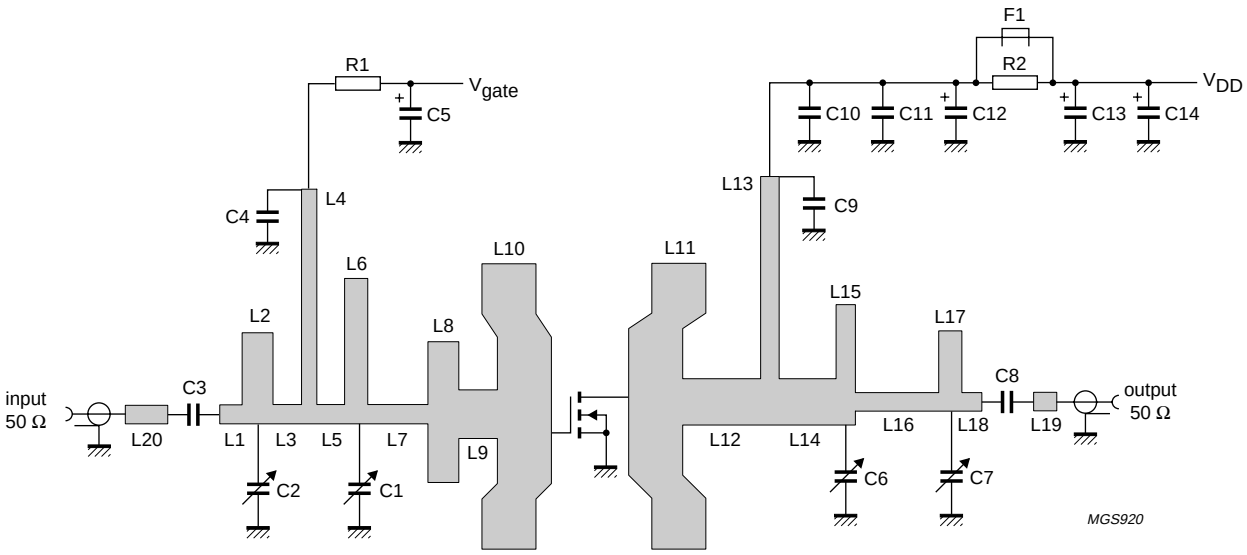


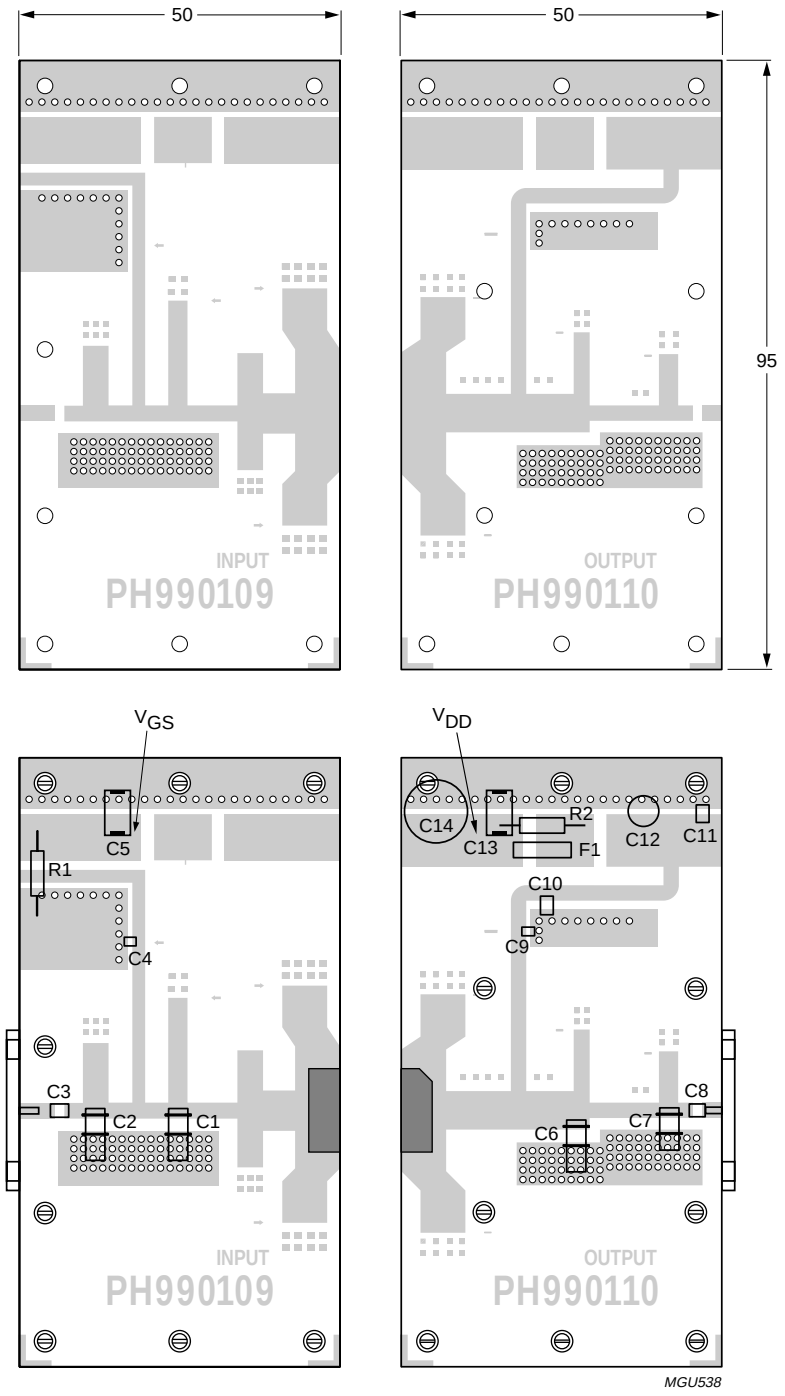
Fig.10 Class-AB test circuit at f = 2.2 GHz.

List of components (See Figs 10 and 11)

COMPONENT	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE NO.
C1, C2, C6, C7	Tekelec variable capacitor; type 37281	0.4 to 2.5 pF		
C3, C8	multilayer ceramic chip capacitor; note 1	12 pF		
C4, C9	multilayer ceramic chip capacitor; note 2	12 pF		
C5, C12	electrolytic capacitor	10 μF; 100 V		2222 037 59109
C10	multilayer ceramic chip capacitor; note 1	1 nF		
C11	multilayer ceramic chip capacitor	100 nF		2222 581 16641
C13	tantalum SMD capacitor	4.5 μF; 50 V		
C14	electrolytic capacitor	100 μF; 63 V		2222 037 58101
F1	Ferroxcube chip-bead 8DS3/3/8/9-4S2			4330 030 36301
L1	stripline; note 3	50 Ω	2.9 × 2.4 mm	
L2	stripline; note 3	14.5 Ω	4 × 11.7 mm	
L3	stripline; note 3	50 Ω	3.7 × 2.4 mm	
L4	stripline; note 3	6 Ω	2 × 30.8 mm	
L5	stripline; note 3	50 Ω	3.6 × 2.4 mm	
L6	stripline; note 3	9.5 Ω	3 × 18.8 mm	
L7	stripline; note 3	50 Ω	7.8 × 2.4 mm	
L8	stripline; note 3	9.8 Ω	4 × 18.3 mm	
L9	stripline; note 3	24.4 Ω	5 × 6.3 mm	
L10, L11	stripline; note 3	5.1 Ω	7 × 37 mm	
L12	stripline; note 3	25.4 Ω	10.1 × 6 mm	
L13	stripline; note 3	5.7 Ω	2.4 × 32.8 mm	
L14	stripline; note 3	25.4 Ω	7.4 × 6 mm	
L15	stripline; note 3	11.3 Ω	2.5 × 15.6 mm	
L16	stripline; note 3	50 Ω	10.8 × 2.4 mm	
L17	stripline; note 3	16.1 Ω	3 × 10.4 mm	
L18	stripline; note 3	50 Ω	2.3 × 2.4 mm	
L19	stripline; note 3	50 Ω	3 × 2.4 mm	
L20	stripline; note 3	50 Ω	5.5 × 2.4 mm	
R1, R2	metal film resistor	10 Ω, 0.6 W		2322 156 11009

Notes

1. American Technical Ceramics type 100B or capacitor of same quality.
2. American Technical Ceramics type 100A or capacitor of same quality.
3. The striplines are on a double copper-clad printed-circuit board with Teflon dielectric (ε_r = 2.2); thickness 0.79 mm.



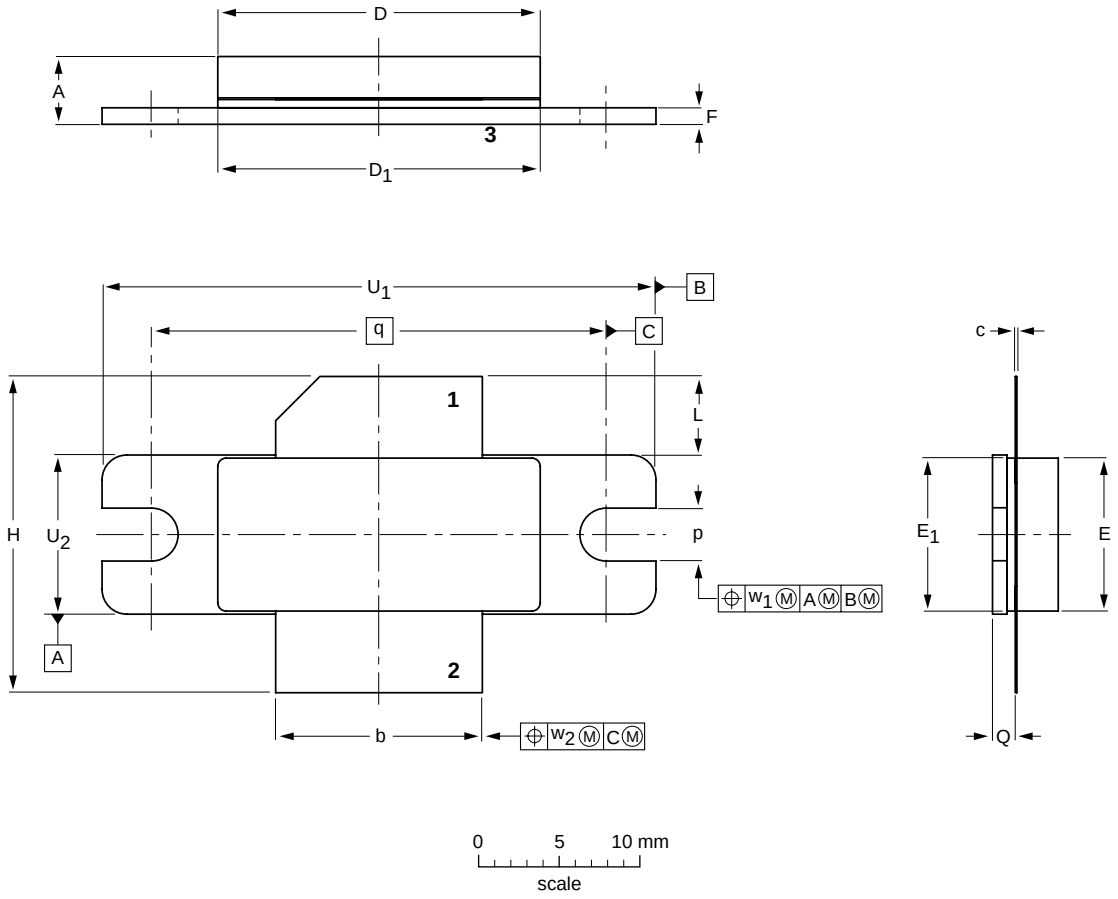
Dimensions in mm.

The components are situated on one side of the copper-clad printed-circuit board with Teflon dielectric (ε_r = 2.2), thickness 0.79 mm. The other side is unetched and serves as a ground plane.

Fig.11 Component layout for 2.2 GHz class-AB test circuit.

PACKAGE OUTLINE

Flanged LDMOST ceramic package; 2 mounting holes; 2 leads **SOT502A**



DIMENSIONS (millimetre dimensions are derived from the original inch dimensions)

UNIT	A	b	c	D	D_1	E	E_1	F	H	L	p	Q	q	U_1	U_2	w_1	w_2
mm	4.72 3.43	12.83 12.57	0.15 0.08	20.02 19.61	19.96 19.66	9.50 9.30	9.53 9.25	1.14 0.89	19.94 18.92	5.33 4.32	3.38 3.12	1.70 1.45	27.94	34.16 33.91	9.91 9.65	0.25	0.51
inches	0.186 0.135	0.505 0.495	0.006 0.003	0.788 0.772	0.786 0.774	0.374 0.366	0.375 0.364	0.045 0.035	0.785 0.745	0.210 0.170	0.133 0.123	0.067 0.057	1.100	1.345 1.335	0.390 0.380	0.01	0.02

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT502A						~~99-12-28~~ 03-01-10

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